

IRW ✓



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

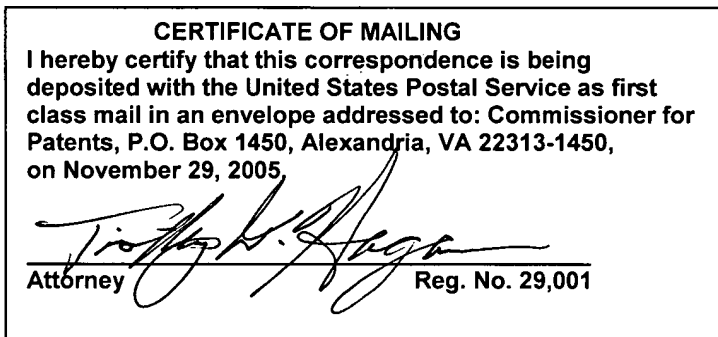
Application of

Applicants : Stuart Lindsay and Tianwei Jing  
Serial No. : 10/725,769  
Filed : December 2, 2003  
Title : **FAST SCANNING STAGE FOR A SCANNING PROBE MICROSCOPE**  
Docket : MOL0077PA/40518.112  
Examiner : B. Livedalen  
Art Unit : 2878  
Conf. No. : 3836

**MAIL STOP AMENDMENT**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:



**AMENDMENT**

This paper is being filed in response to the Office Action mailed August 3, 2005. Accompanying this paper is a separate request by applicants for a one-month extension of time in which to respond to the Office Action, making a due date for response of December 3, 2005. Reconsideration and reexamination are respectfully requested in light of the amendments and remarks below.

This amendment uses the Revised Amendment Practice. The entire set of presently pending claims has been reproduced below in the approved revised amendment format. Amendments relating to the specification, claims, and/or drawings begin on separate pages of this paper. Any amendments to the specification and drawings have also been presented in the revised format. No separate marked-up copy of the amended specification and/or claims has been provided.